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Journal of Non-Crystalline Solids 282 (2001) 335–337

JOURNAL OF NON-CRYSTALLINE SOLIDS

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Author Index

Abe, K., O. Uemura, T. Usuki, Y. Kameda and M. Sakurai, Local atomic arrangement in amorphous As–Se–Br System 282 (2001) 173
Acet, M., see Saunders, G.A. 282 (2001) 291
Ashbrook, S.E., see McManus, J. 282 (2001) 278
Ayres, A.M., see Lima, E.C.D. 282 (2001) 333

Barkema, G.T., see Vink, R.L.C. 282 (2001) 248
Bessinger, D., J.M.A. Geldenhuis, P.C. Pistorius, A. Mulaba and G. Hearne, The decrepitation of solidified high titania slags 282 (2001) 132
Bogomolova, L.D., N.A. Krasil'nikova, S.A. Prushinsky, O.A. Trul and S.V. Stefanovsky, EPR of fluoroaluminate glasses implanted with titanium 282 (2001) 329
Brennan, T., see Saunders, G.A. 282 (2001) 291

Cankurtaran, M., see Saunders, G.A. 282 (2001) 291
Chevrier, V., see Lee, S.H. 282 (2001) 41
Cho, J.W. and H. Shibata, Effect of solidification of mold fluxes on the heat transfer in casting mold 282 (2001) 110
Choi, S.-Y., see Sohn, S.-B. 282 (2001) 221
Chuvaeva, T.I., O.S. Dymshits, V.I. Petrov, M.Ya. Tsenter, A.V. Shashkin, A.A. Zhilin and V.V. Golubkov, Low-frequency Raman scattering of magnesium aluminosilicate glasses and glass-ceramics 282 (2001) 306
Cramb, A.W., see Lee, S.H. 282 (2001) 41

Dekkers, R., C.F. Woensdregt and P. Wollants, Surface modelling of crystalline non-metallic inclusions 282 (2001) 49
Domínguez-Espinós, O., see Martínez, J.R. 282 (2001) 317
Dymshits, O.S., see Chuvaeva, T.I. 282 (2001) 306

Federico, M., see Saunders, G.A. 282 (2001) 291
Fujino, S., see Morinaga, K. 282 (2001) 118

Gaye, H., see Lehmann, J. 282 (2001) 61
Gaye, H., see Rocabois, P. 282 (2001) 98
Geldenhuis, J.M.A., see Bessinger, D. 282 (2001) 132
Golubkov, V.V., see Chuvaeva, T.I. 282 (2001) 306
Gong, J., W. Si and Z. Guan, Effect of load-dependence of hardness on indentation toughness determination for soda-lime glass 282 (2001) 325
Guan, Z., see Gong, J. 282 (2001) 325
Güngör, T. and H. Tolunay, Drift mobility measurements in a-SiN$_x$:H 282 (2001) 197

Hayashi, M., see Nagata, K. 282 (2001) 1
Hayashi, Y., K. Matsumoto and M. Kudo, The diffusion mechanism of tin into glass governed by redox reactions during the float process 282 (2001) 188
Hearne, G., see Bessinger, D. 282 (2001) 132

Jahanshahi, S., see Wright, S. 282 (2001) 15
Jahanshahi, S., see Zhang, L. 282 (2001) 24
Jiang, G., see You, J. 282 (2001) 125

Kameda, Y., see Abe, K. 282 (2001) 173
Kamenev, B.V., see Konstantinova, E.A. 282 (2001) 321
Kameshima, Y., see Takei, T. 282 (2001) 265
Kashkarov, P.K., see Konstantinova, E.A. 282 (2001) 321
Keding, R., see Mastelaro, V.R. 282 (2001) 181
Kinomura, N., see Takei, T. 282 (2001) 265
Klein, J., C. Lettmann and W.F. Maier, Thermally stable, silica-based amorphous porous mixed oxides prepared by sol–gel procedures 282 (2001) 203
Konstantinova, E.A., B.V. Kamenev, P.K. Kashkarov, V.Yu. Timoshenko, V.Kh. Kudoyarova and E.I. Terukov, Correlation between photoluminescence efficiency and density of paramagnetic defects in Er-doped hydrogenated amorphous silicon 282 (2001) 321
Krasil'nikova, N.A., see Bogomolova, L.D. 282 (2001) 329
Kudo, M., see Hayashi, Y. 282 (2001) 188
Kudoyarova, V.Kh., see Konstantinova, E.A. 282 (2001) 321
Kumada, N., see Takei, T. 282 (2001) 265

0022-3093/01/$ - see front matter © 2001 Elsevier Science B.V. All rights reserved.
PII: S0022-3093(01)00497-5

Lee, S.H., C. Tse, K.W. Yi, P. Misra, V. Chevrier, C. Orrling, S. Sridhar and A.W. Cramb, Separation and dissolution of Al_2O_3 inclusions at slag/metal interfaces 282 (2001) 41

Lehmann, J., P. Rocabois and H. Gaye, Kinetic model of non-metallic inclusions' precipitation during steel solidification 282 (2001) 61

Lehmann, J., see Rocabois, P. 282 (2001) 98

Lettmann, C., see Klein, J. 282 (2001) 203

Lima, E.C.D., P.P.C. Sartoratto, A.M. Ayres and S.B. Oliveira, Erratum to: "Aluminium/sodium phosphate-based closed cell ceramic foams" [J. Non-Cryst. Solids 279 (2001) 60–71] 282 (2001) 333

Löser, C. and C. Rüssel, The crystallization of indium containing semiconductive phases from a soda–lime–aluminosilicate glass 282 (2001) 228

MacKenzie, K.J.D., see McManus, J. 282 (2001) 278

Maier, W.F., see Klein, J. 282 (2001) 203

Martínez, J.R., G. Ortega-Zarzosa, O. Domínguez-Espinós and F. Ruiz, Low temperature devitrification of Ag/SiO_2 and $Ag(CuO)/SiO_2$ composites 282 (2001) 317

Mastelaro, V.R. and R. Keding, X-ray absorption spectroscopy investigation of $Ba_2TiSi_2O_8 + xSiO_2$ glasses 282 (2001) 181

Matsumoto, K., see Hayashi, Y. 282 (2001) 188

McManus, J., S.E. Ashbrook, K.J.D. MacKenzie and S. Wimperis, ^{27}Al multiple-quantum MAS and $^{27}Al\{^1H\}$ CPMAS NMR study of amorphous aluminosilicates 282 (2001) 278

Misra, P., see Lee, S.H. 282 (2001) 41

Morinaga, K. and S. Fujino, Preparation and properties of $SnO–SnCl_2–P_2O_5$ glass 282 (2001) 118

Mousseau, N., see Vink, R.L.C. 282 (2001) 248

Mulaba, A., see Bessinger, D. 282 (2001) 132

Nagasaki, S., see Shiraishi, Y. 282 (2001) 86

Nagata, K. and M. Hayashi, Structure relaxation of silicate melts containing iron oxide 282 (2001) 1

Nowack, N., S. Okretic, F. Pfeifer and I. Zebger, Ultraviolet/visible spectroscopy of molten slags and glasses (up to 1600°C) 282 (2001) 30

Okada, K., see Takei, T. 282 (2001) 265

Okretic, S., see Nowack, N. 282 (2001) 30

Oliveira, S.B., see Lima, E.C.D. 282 (2001) 333

Orrling, C., see Lee, S.H. 282 (2001) 41

Ortega-Zarzosa, G., see Martínez, J.R. 282 (2001) 317

Otaigbe, J.U., see Tischendorf, B. 282 (2001) 147

Ottonello, G., Thermodynamic constraints arising from the polymeric approach to silicate slags: the system $CaO–FeO–SiO_2$ as an example 282 (2001) 72

Park, J.-H. and P.C.-H. Rhee, Ionic properties of oxygen in slag 282 (2001) 7

Petrov, V.I., see Chuvaeva, T.I. 282 (2001) 306

Pfeifer, F., see Nowack, N. 282 (2001) 30

Pistorius, P.C., see Bessinger, D. 282 (2001) 132

Pontoire, J.N., see Rocabois, P. 282 (2001) 98

Prushinsky, S.A., see Bogomolova, L.D. 282 (2001) 329

Pruski, M., see Tischendorf, B. 282 (2001) 147

Rhee, P.C.-H., see Park, J.-H. 282 (2001) 7

Rocabois, P., J.N. Pontoire, J. Lehmann and H. Gaye, Crystallization kinetics of $Al_2O_3–CaO–SiO_2$ based oxide inclusions 282 (2001) 98

Rocabois, P., see Lehmann, J. 282 (2001) 61

Ruiz, F., see Martínez, J.R. 282 (2001) 317

Rüssel, C., see Löser, C. 282 (2001) 228

Sacher, E., see Sheng, S. 282 (2001) 165

Sakai, M. and S. Shimizu, Indentation rheometry for glass-forming materials 282 (2001) 236

Sakurai, M., see Abe, K. 282 (2001) 173

Sales, B.C., see Tischendorf, B. 282 (2001) 147

Sartoratto, P.P.C., see Lima, E.C.D. 282 (2001) 333

Saunders, G.A., T. Brennan, M. Acet, M. Cankurtaran, H.B. Senin, H.A.A. Sidek and M. Federico, Elastic and non-linear acoustic properties and thermal expansion of cerium metaphosphate glasses 282 (2001) 291

Senin, H.B., see Saunders, G.A. 282 (2001) 291

Shashkin, A.V., see Chuvaeva, T.I. 282 (2001) 306

Sheng, S., E. Sacher and A. Yelon, Structural changes in amorphous silicon studied by X-ray photoemission spectroscopy: a phenomenon independent of the Staebler–Wronski effect? 282 (2001) 165

Shibata, H., see Cho, J.W. 282 (2001) 110

Shimizu, S., see Sakai, M. 282 (2001) 236

Shiraishi, Y., S. Nagasaki and M. Yamashiro, Viscosity of potassium boro-silicate system in glassy and liquid states 282 (2001) 86

Si, W., see Gong, J. 282 (2001) 325

Sidek, H.A.A., see Saunders, G.A. 282 (2001) 291

Sohn, S.-B. and S.-Y. Choi, Crystallization behavior in the glass system

$MgO–Al_2O_3–SiO_2$: influence of CeO_2 addition 282 (2001) 221
Sridhar, S., see Lee, S.H. 282 (2001) 41
Stefanovsky, S.V., see Bogomolova, L.D. 282 (2001) 329
Sun, S., see Wright, S. 282 (2001) 15
Sun, S., see Zhang, L. 282 (2001) 24

Takei, T., Y. Kameshima, A. Yasumori, K. Okada, N. Kumada and N. Kinomura, SAXS analysis of textures formed by phase separation and crystallization of $Al_2O_3–SiO_2$ glasses 282 (2001) 265
Terukov, E.I., see Konstantinova, E.A. 282 (2001) 321
Timoshenko, V.Yu., see Konstantinova, E.A. 282 (2001) 321
Tischendorf, B., J.U. Otaigbe, J.W. Wiench, M. Pruski and B.C. Sales, A study of short and intermediate range order in zinc phosphate glasses 282 (2001) 147
Tokuda, Y., T. Uchino and T. Yoko, Vibrational dynamics of glassy SiS_2 on the basis of molecular orbital calculations 282 (2001) 256
Tolunay, H., see Güngör, T. 282 (2001) 197
Trul, O.A., see Bogomolova, L.D. 282 (2001) 329
Tse, C., see Lee, S.H. 282 (2001) 41
Tsenter, M.Ya., see Chuvaeva, T.I. 282 (2001) 306

Uchino, T., see Tokuda, Y. 282 (2001) 256
Uemura, O., see Abe, K. 282 (2001) 173
Usuki, T., see Abe, K. 282 (2001) 173

van der Weg, W.F., see Vink, R.L.C. 282 (2001) 248
Vink, R.L.C., G.T. Barkema, W.F. van der Weg and N. Mousseau, Fitting the Stillinger–Weber potential to amorphous silicon 282 (2001) 248

Wiench, J.W., see Tischendorf, B. 282 (2001) 147
Wimperis, S., see McManus, J. 282 (2001) 278
Woensdregt, C.F., see Dekkers, R. 282 (2001) 49
Wollants, P., see Dekkers, R. 282 (2001) 49
Wright, S., L. Zhang, S. Sun and S. Jahanshahi, Viscosities of calcium ferrite slags and calcium aluminosilicate slags containing spinel particles 282 (2001) 15

Xu, K., see You, J. 282 (2001) 125

Yamashiro, M., see Shiraishi, Y. 282 (2001) 86
Yasumori, A., see Takei, T. 282 (2001) 265
Yelon, A., see Sheng, S. 282 (2001) 165
Yi, K.W., see Lee, S.H. 282 (2001) 41
Yoko, T., see Tokuda, Y. 282 (2001) 256
You, J., G. Jiang and K. Xu, High temperature Raman spectra of sodium disilicate crystal, glass and its liquid 282 (2001) 125

Zebger, I., see Nowack, N. 282 (2001) 30
Zhang, L., S. Sun and S. Jahanshahi, Molecular dynamics simulations of silicate slags and slag–solid interfaces 282 (2001) 24
Zhang, L., see Wright, S. 282 (2001) 15
Zhang, M., see Zhang, Y. 282 (2001) 159
Zhang, Y. and M. Zhang, Microstructural and mechanical characterization of chitosan scaffolds reinforced by calcium phosphates 282 (2001) 159
Zhilin, A.A., see Chuvaeva, T.I. 282 (2001) 306

ELSEVIER

Journal of Non-Crystalline Solids 282 (2001) 338–340

JOURNAL OF NON-CRYSTALLINE SOLIDS

www.elsevier.com/locate/jnoncrysol

Subject Index

Absorption
Quantum Wells, Semiconductors 282 (2001) 228

Acoustic Properties
Elastic Properties, Phosphates, Thermal Expansion 282 (2001) 291

Alkali Silicate Glasses
Liquids, Raman Spectra, Structure 282 (2001) 125

Aluminates
Liquids, Microstructure 282 (2001) 41

Aluminosilicates
Crystallization, Phase Separation, Small Angle X-ray Scattering 282 (2001) 265
Raman Spectra 282 (2001) 306

Amorphous Semiconductors
Electronic Conductivity, Silicon 282 (2001) 197
Molecular Dynamics, Silicon 282 (2001) 248

Borosilicates
Liquids, Viscosity 282 (2001) 86

Chalcogenides
Raman Spectra, Structure, X-ray Absorption 282 (2001) 173

Crystallization
282 (2001) 159
282 (2001) 221
282 (2001) 317
Aluminosilicates, Phase Separation, Small Angle X-ray Scattering 282 (2001) 265
Kinetics, Melting, Particles 282 (2001) 61
Microstructure, Oxide Melts, Thermal Properties 282 (2001) 110
Oxides 282 (2001) 98

Diffusion
Float Glass, Tin Oxide 282 (2001) 188

Elastic Properties
Acoustic Properties, Phosphates, Thermal Expansion 282 (2001) 291

Electron Spin Resonance
Fluoride Glasses, Ion Implantation 282 (2001) 329

Electronic Conductivity
Amorphous Semiconductors, Silicon 282 (2001) 197

Float Glass
Diffusion, Tin Oxide 282 (2001) 188

Fluoride Glasses
Electron Spin Resonance, Ion Implantation 282 (2001) 329

Fracture
Hardness 282 (2001) 325

Glass Transition
Phosphates, Processing Variables, Thermal Properties, Tin Oxide 282 (2001) 118
Viscoelasticity 282 (2001) 236

Hardness
Fracture 282 (2001) 325

Interfaces
Molecular Dynamics, Silicates 282 (2001) 24

Ion Implantation
Electron Spin Resonance, Fluoride Glasses 282 (2001) 329

Kinetics
Crystallization, Melting, Particles 282 (2001) 61

Liquids
Alkali Silicate Glasses, Raman Spectra, Structure 282 (2001) 125
Aluminates, Microstructure 282 (2001) 41
Borosilicates, Viscosity 282 (2001) 86
Particles, Silicates, Viscosity 282 (2001) 15

Luminescence
Secondary Electron Emission, Silicon 282 (2001) 321

Melting
Crystallization, Kinetics, Particles 282 (2001) 61

Microstructure
Aluminates, Liquids 282 (2001) 41
Crystallization, Oxide Melts, Thermal Properties 282 (2001) 110

0022-3093/01/$ - see front matter © 2001 Elsevier Science B.V. All rights reserved.
PII: S0022-3093(01)00498-7

Modelling
Silicates, Surface Analysis 282 (2001) 49

Molecular Dynamics
Amorphous Semiconductors, Silicon 282 (2001) 248
Interfaces, Silicates 282 (2001) 24

Molecular Orbital Calculation
Raman Spectra 282 (2001) 256

Nuclear Magnetic Resonance
Phosphates, Raman Spectra, Structure 282 (2001) 147
Structure 282 (2001) 278

Optical Properties
Oxide Melts, Ultraviolet Absorption 282 (2001) 30

Oxide Melts
Crystallization, Microstructure, Thermal Properties 282 (2001) 110
Optical Properties, Ultraviolet Absorption 282 (2001) 30
Silicates, XPS 282 (2001) 7

Oxides
Crystallization 282 (2001) 98

Particles
Crystallization, Kinetics, Melting 282 (2001) 61
Liquids, Silicates, Viscosity 282 (2001) 15

Phase Separation
Aluminosilicates, Crystallization, Small Angle X-ray Scattering 282 (2001) 265

Phosphates
Acoustic Properties, Elastic Properties, Thermal Expansion 282 (2001) 291
Glass Transition, Processing Variables, Thermal Properties, Tin Oxide 282 (2001) 118
Nuclear Magnetic Resonance, Raman Spectra, Structure 282 (2001) 147

Polymer Network
Silicates, Thermodynamics 282 (2001) 72

Porosity
Sol–Gel Processes 282 (2001) 203

Processing Variables
Glass Transition, Phosphates, Thermal Properties, Tin Oxide 282 (2001) 118

Quantum Wells
Absorption, Semiconductors 282 (2001) 228

Raman Spectra
Alkali Silicate Glasses, Liquids, Structure 282 (2001) 125
Aluminosilicates 282 (2001) 306
Chalcogenides, Structure, X-ray Absorption 282 (2001) 173
Molecular Orbital Calculation 282 (2001) 256
Nuclear Magnetic Resonance, Phosphates, Structure 282 (2001) 147

Secondary Electron Emission
Luminescence, Silicon 282 (2001) 321

Semiconductors
Absorption, Quantum Wells 282 (2001) 228

Silicates
Interfaces, Molecular Dynamics 282 (2001) 24
Liquids, Particles, Viscosity 282 (2001) 15
Modelling, Surface Analysis 282 (2001) 49
Oxide Melts, XPS 282 (2001) 7
Polymer Network, Thermodynamics 282 (2001) 72
Silicon, Titania 282 (2001) 132
Structural Relaxation, Transition Metals 282 (2001) 1

Silicon
Amorphous Semiconductors, Electronic Conductivity 282 (2001) 197
Amorphous Semiconductors, Molecular Dynamics 282 (2001) 248
Luminescence, Secondary Electron Emission 282 (2001) 321
Silicates, Titania 282 (2001) 132
Structure, XPS 282 (2001) 165

Small Angle X-ray Scattering
Aluminosilicates, Crystallization, Phase Separation 282 (2001) 265

Sol–Gel Processes
Porosity 282 (2001) 203

Structural Relaxation
Silicates, Transition Metals 282 (2001) 1

Structure
Alkali Silicate Glasses, Liquids, Raman Spectra 282 (2001) 125
Chalcogenides, Raman Spectra, X-ray Absorption 282 (2001) 173
Nuclear Magnetic Resonance 282 (2001) 278
Nuclear Magnetic Resonance, Phosphates, Raman Spectra 282 (2001) 147
Silicon, XPS 282 (2001) 165

Surface Analysis
Modelling, Silicates 282 (2001) 49

Thermal Expansion
Acoustic Properties, Elastic Properties, Phosphates 282 (2001) 291

Thermal Properties
Crystallization, Microstructure, Oxide Melts 282 (2001) 110

Glass Transition, Phosphates, Processing Variables, Tin Oxide 282 (2001) 118

Thermodynamics
Polymer Network, Silicates 282 (2001) 72

Tin Oxide
Diffusion, Float Glass 282 (2001) 188
Glass Transition, Phosphates, Processing Variables, Thermal Properties 282 (2001) 118

Titania
Silicates, Silicon 282 (2001) 132

Transition Metals
Silicates, Structural Relaxation 282 (2001) 1

Ultraviolet Absorption
Optical Properties, Oxide Melts 282 (2001) 30

Viscoelasticity
Glass Transition 282 (2001) 236

Viscosity
Borosilicates, Liquids 282 (2001) 86
Liquids, Particles, Silicates 282 (2001) 15

XPS
Oxide Melts, Silicates 282 (2001) 7
Silicon, Structure 282 (2001) 165

X-ray Absorption
282 (2001) 181
Chalcogenides, Raman Spectra, Structure 282 (2001) 173